

### General Description

These miniature surface mount MOSFETs utilize a high cell density trench process to provide low RDS(on) and to ensure minimal power loss and heat dissipation. Typical applications are DC-DC converters and power management in portable and battery-powered products such as computers, printers, PCMCIA cards, cellular and cordless telephones.

### Features

- Advanced high cell density Trench technology
- Fast switching speed
- Lower On-resistance
- 100% EAS Guaranteed
- Simple Drive Requirement

### Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	-30	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D @ T_C = 25^\circ\text{C}$	Continuous Drain Current	-50	A
$I_D @ T_C = 100^\circ\text{C}$	Continuous Drain Current	-25	A
$I_{DM}$	Pulsed Drain Current <sup>1</sup>	-150	A
EAS	Single Pulse Avalanche Energy <sup>2</sup>	156	mJ
$I_{AS}$	Single Pulse Avalanche Current	-50	A
$P_D @ T_C = 25^\circ\text{C}$	Total Power Dissipation	60	W
$T_{STG}$	Storage Temperature Range	-55 to 175	°C
$T_J$	Operating Junction Temperature Range	-55 to 175	°C

### Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Junction-to-Ambient <sup>3</sup>	---	50	°C/W
$R_{\theta JC}$	Junction-to-Case (Drain)	---	1.1	°C/W

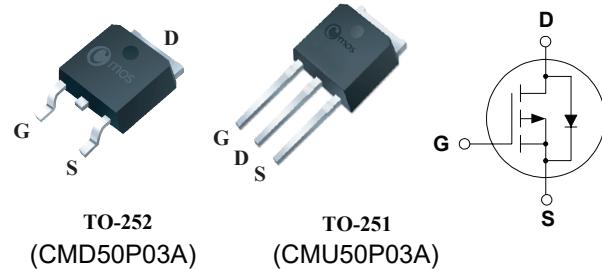
### Product Summary

BVDSS	RDS <sub>ON</sub>	ID
-30V	12mΩ	-50A

### Applications

- DC-DC Converters
- Desktop PCs
- LED controller

### TO-252/251 Pin Configuration



**Electrical Characteristics (T<sub>J</sub>=25°C , unless otherwise noted)**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =-250uA	-30	---	---	V
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance <sup>1</sup>	V <sub>GS</sub> =-10V, I <sub>D</sub> =-15A	---	---	12	mΩ
		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-10A	---	---	16	
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =-250uA	-1	---	-2.5	V
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =-24V, V <sub>GS</sub> =0V , T <sub>J</sub> =25°C	---	---	-1	uA
		V <sub>DS</sub> =-24V, V <sub>GS</sub> =0V , T <sub>J</sub> =125°C	---	---	-50	
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> = ±20V , V <sub>DS</sub> =0V	---	---	±100	nA
g <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =-5V, I <sub>D</sub> =-10A	---	26	---	S
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =-24V, I <sub>D</sub> =-50A	---	40	---	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> =0 to -10V	---	6	---	
Q <sub>gd</sub>	Gate-Drain Charge		---	10	---	
T <sub>d(on)</sub>	Turn-On Delay Time		---	11	---	ns
T <sub>r</sub>	Rise Time	V <sub>DD</sub> =-15V, V <sub>GS</sub> =-10V, R <sub>G</sub> =3.5Ω	---	9	---	
T <sub>d(off)</sub>	Turn-Off Delay Time	I <sub>D</sub> =-50A	---	54	---	
T <sub>f</sub>	Fall Time		---	20	---	
C <sub>iss</sub>	Input Capacitance		---	1800	---	pF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> =-25V, V <sub>GS</sub> =0V , f=1MHz	---	300	---	
C <sub>rss</sub>	Reverse Transfer Capacitance		---	220	---	

**Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I <sub>S</sub>	Continuous Source Current	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current	---	---	-50	A
I <sub>SM</sub>	Pulsed Source Current <sup>1</sup>		---	---	-150	A
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> =0V , I <sub>F</sub> =-20A	---	---	-1.5	V

**Notes**

1. Pulse test; pulse width≤ 300μs, duty cycle≤ 2%.
- 2.The EAS data shows Max. rating . The test condition is V<sub>DD</sub>=-25V,V<sub>GS</sub>=-10V,L=0.5mH,I<sub>AS</sub>=-25A.
3. When mounted on 1 " square PCB (FR-4 material).

This product has been designed and qualified for the consumer market.

Cmos assumes no liability for customers' product design or applications.

Cmos reserves the right to improve product design ,functions and reliability without notice.